TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

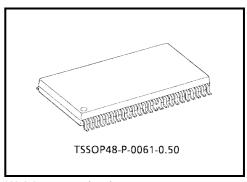
TC74LCX16245FT

Low-Voltage 16-Bit Bus Transceiver with 5-V Tolerant Inputs and Outputs

The TC74LCX16245FT is a high-performance CMOS 16-bit bus transceiver. Designed for use in 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

The device is designed for low-voltage (2.5-V or 3.3-V) VCC applications, but it could be used to interface to 5-V supply environment for both inputs and outputs.

This 16-bit bus transceiver is controlled by direction control (DIR) inputs and output enable (\overline{OE}) inputs which are common to each byte. It can be used as two 8-bit transceiver or one 16-bit transceiver. The direction of data transmission is determined by the level of the DIR inputs. The \overline{OE} inputs can be used to disable the device so that the busses are effectively isolated.



Weight: 0.25 g (typ.)

All inputs are equipped with protection circuits against static discharge.

Features

- Low-voltage operation: $V_{CC} = 2.0$ to 3.6 V
- High-speed operation: $t_{pd} = 4.5 \text{ ns (max)} (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$
- Ouput current: $|I_{OH}|/I_{OL} = 24 \text{ mA (min)} (V_{CC} = 3.0 \text{ V})$
- Latch-up performance: ±500 mA
- Package: TSSOP (thin shrink small outline package)
- Bidirectional interface between 5.0 V and low-voltage (2.5-V or 3.3-V) signals
- Power-down protection provided on all inputs and outputs

Note: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

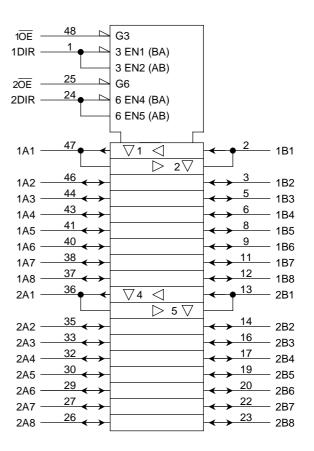
All floating (high impedance) bus pins must have their input level fixed by means of pull-up or pull-down resistors.

1

Pin Assignment (top view)

48 1DIR 10E 1B1 2 47 1A1 3 1B2 1A2 46 GND 4 **GND** 45 5 1B3 1A3 1B4 6 43 1A4 V_{CC} 7 V_{CC} 42 1B5 8 1A5 1B6 9 40 1A6 GND 10 **GND** 39 1B7 11 38 1A7 1B8 12 37 1A8 2B1 13 36 2A1 2B2 14 35 2A2 GND 15 GND 34 2B3 16 33 2A3 2B4 17 32 2A4 V_{CC} 18 31 Vcc 2B5 19 30 2A5 2B6 20 29 2A6 GND 21 **GND** 2B7 22 2A7 27 2B8 23 26 2A8 2DIR 24 2OE 25

IEC Logic Symbol



Truth Table

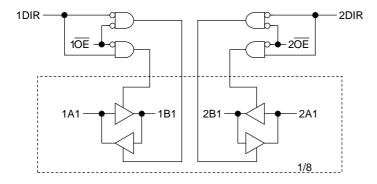
Inp	uts	Fun		
1 OE	1DIR	Bus 1A1-1A8	Bus 1B1-1B8	Outputs
L	L	Output Input		A = B
L	Н	Input Output		B=A
Н	Х	Z		Z

Inp	uts	Fun	ction	
2 OE	2DIR	Bus 2A1-2A8	Bus 2B1-2B8	Outputs
L	L	Output	Input	A = B
L	Н	Input Output		B=A
Н	Х	Z		Z

X: Don't care

Z: High impedance

System Diagram



3



Maximum Ratings

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V_{CC}	-0.5 to 6.0	V	
DC input voltage (DIR, $\overline{\text{OE}}$)	V _{IN}	-0.5 to 7.0	V	
DC bus I/O voltage	V _{I/O}	-0.5 to 7.0 (Note 1)	V	
DC bus I/O voltage	V 1/O	$-0.5 \text{ to V}_{CC} + 0.5 \text{(Note 2)}$	v	
Input diode current	I _{IK}	-50	mA	
Output diode current	lok	±50 (Note 3)	mA	
DC output current	lout	±50	mA	
Power dissipation	P _D	400	mW	
DC V _{CC} /ground current per supply pin	I _{CC} /I _{GND}	±100	mA	
Storage temperature	T _{stg}	-65 to 150	°C	

Note 1: Output in OFF state

Note 2: High or low state. $I_{\mbox{OUT}}$ absolute maximum rating must be observed.

Note 3: $V_{OUT} < GND, V_{OUT} > V_{CC}$

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V	2.0 to 3.6	V	
Fower supply voltage	V _{CC}	1.5 to 3.6 (Note 4)		
Input voltage (DIR, $\overline{\sf OE}$)	V _{IN}	0 to 5.5	V	
Bus I/O voltage	V _{I/O}	0 to 5.5 (Note 5)	V	
Dus I/O Voltage	V 1/O	0 to V _{CC} (Note 6)		
		±24 (Note 7)		
Output current	I _{OH} /I _{OL}	±12 (Note 8)	mA	
		±8 (Note 9)		
Operating temperature	T _{opr}	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 10 (Note 10)	ns/V	

Note 4: Data retention only

Note 5: Output in OFF state

Note 6: High or low state

Note 7: $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$

Note 8: $V_{CC} = 2.7 \text{ to } 3.0 \text{ V}$

Note 9: $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$

Note 10: $V_{IN} = 0.8$ to 2.0 V, $V_{CC} = 3.0$ V



Electrical Characteristics

DC Characteristics ($Ta = -40 \text{ to } 85^{\circ}\text{C}$)

Characteristics Symbol		Test Condition		V 00	Min	Max	Unit				
					V _{CC} (V)	1.7					
	H-level	V_{IH}	_	_	2.7 to 3.6	2.0	_				
Input voltage								V			
	L-level	VIL	_	_	2.3 to 2.7		0.7				
				_	2.7 to 3.6		0.8				
				$I_{OH} = -100 \ \mu A$	2.3 to 3.6	V _{CC} - 0.2	_				
				$I_{OH} = -8 \text{ mA}$	2.3	1.8					
	H-level	V _{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -12 \text{ mA}$ 2.7	2.7	2.2					
				I _{OH} = -18 m	$I_{OH} = -18 \text{ mA}$ 3.0	3.0	2.4	_			
Output voltage				I _{OH} = -24 mA	3.0	2.2	_	V			
			V _{IN} = V _{IH} or V _{IL}	$I_{OL} = 100 \mu A$	2.3 to 3.6	_	0.2				
				I _{OL} = 8 mA	2.3	_	0.6				
	L-level	V _{OL}		I _{OL} = 12 mA	2.7	_	0.4				
							I _{OL} = 16 mA	3.0	_	0.4	
				I _{OL} = 24 mA	3.0	_	0.55				
Input leakage current		I _{IN}	V _{IN} = 0 to 5.5 V		2.3 to 3.6	_	±5.0	μΑ			
0 -1-11-1- 055 -1-1			$V_{IN} = V_{IH}$ or V_{IL}		2.3 to 3.6		±5.0				
3-state output OFF state current		I _{OZ}	V _{OUT} = 0 to 5.5 V		2.3 10 3.6	_	±3.0	μА			
Power-off leakage curr	rent	I _{OFF}	$V_{IN}/V_{OUT} = 5.5 \text{ V}$		0	_	10.0	μΑ			
Ouissant summit summer		Icc	$V_{IN} = V_{CC}$ or GND		2.3 to 3.6	_	20.0				
Quiescent supply curre	Quiescent supply current		V _{IN} /V _{OUT} = 3.6 to 5.5 V		2.3 to 3.6		±20.0	μΑ			
Increase in Icc per inpu	ut	Δlcc	$V_{IH} = V_{CC} - 0.6 V$		2.3 to 3.6	_	500				

AC Characteristics ($Ta = -40 \text{ to } 85^{\circ}\text{C}$)

Characteristics	Symbol	nbol Test Condition			Min	Max	Unit
Characteristics			V _{CC} (V)	CL(pF)	IVIIII		
	t		2.5 ± 0.2	30	1.5	5.4	
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.7	50	1.5	5.2	ns
	^t pHL		3.3 ± 0.3	50	1.5	4.5	
	+		2.5 ± 0.2	30	1.5	8.5	
3-state output enable time	^t pZL ^t pZH	Figure 1, Figure 3	2.7	50	1.5	7.2	ns
			3.3 ± 0.3	50	1.5	6.5	
	4		2.5 ± 0.2	30	1.5	7.7	
3-state output disable time	t _{pLZ}	Figure 1, Figure 3	2.7	50	1.5	6.9	ns
			3.3 ± 0.3	50	1.5	6.0	
Output to output skew			2.5 ± 0.2	30			
	t _{os} h t _{os} hl	(Note 11)	2.7	50			ns
			3.3 ± 0.3	50	_	1.0	

Note 11: Parameter guaranteed by design. $(t_{OSLH} = |t_{DLHm} - t_{DLHn}|, \, t_{OSHL} = |t_{DHLm} - t_{DHLn}|)$

Dynamic Switching Characteristics (Ta = 25°C, input: $t_r = t_f = 2.5$ ns, $R_L = 500 \Omega$)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Quiet output maximum	V _{OLP}	V _{IH} = 2.5 V, V _{IL} = 0 V, C _L =30pF	2.5	0.6	V
dynamic V _{OL}	VOLP	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}, C_L = 50 \text{pF}$	3.3	0.8	٧
Quiet output minimum	V _{OLV}	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}, C_L = 30 \text{pF}$	2.5	0.6	V
dynamic V _{OL}	I V OLVI	V _{IH} = 3.3 V, V _{IL} = 0 V, C _L =50pF	3.3	0.8	٧

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition		V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}	_		3.3	7	pF
Bus input capacitance	C _{I/O}	_		3.3	8	pF
Power dissipation capacitance	C _{PD}	$f_{IN} = 10 \text{ MHz}$ (N	Note 12)	3.3	25	pF

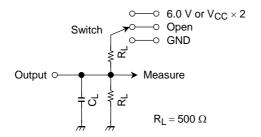
Note 12: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

6

Average operating current can be obtained by the equation:

 $I_{CC \text{ (opr)}} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/16 \text{ (per bit)}$

AC Test Circuit



Parameter	Switch	
t _{pLH} , t _{pHL}	Open	
t _{pLZ} , t _{pZL}		
t _{pHZ} , t _{pZH}	GND	

Figure 1

AC Waveform

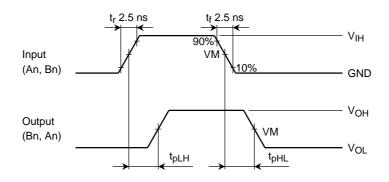


Figure 2 t_{pLH}, t_{pHL}

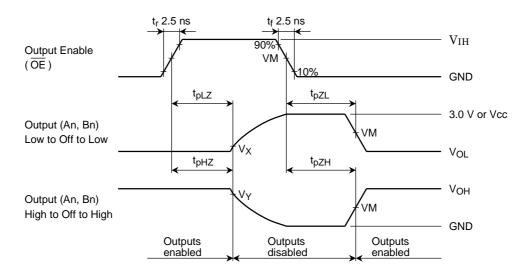


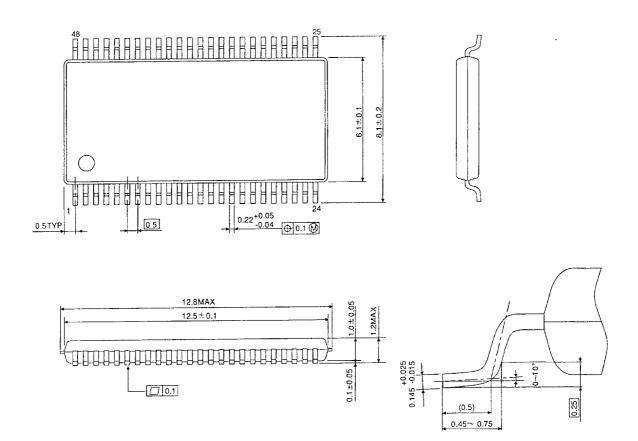
Figure 3 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

Symbol	V _{CC}						
Symbol	$3.3\pm0.3~\textrm{V}$	2.7 V	$2.5\pm0.2\textrm{V}$				
V_{IH}	2.7 V	2.7 V	Vcc				
V _M	1.5 V	1.5 V	V _{CC} /2				
VX	$V_{OL} + 0.3 V$	V _{OL} + 0.3 V	V _{OL} + 0.15 V				
VY	V _{OH} – 0.3 V	V _{OH} – 0.3 V	V _{OH} – 0.15 V				

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Package Dimensions

TSSOP48-P-0061-0.50 Unit: mm



8

Weight: 0.25 g (typ.)

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